


<b>Search Notes</b>  	<b>Application/Control No.</b>  10699593	<b>Applicant(s)/Patent Under Reexamination</b>  SEKI ET AL.
	<b>Examiner</b>  Chen, Junpeng	<b>Art Unit</b>  2618

SEARCHED			
Class	Subclass	Date	Examiner
455	562.1,69,277.1,101,522	03/22/2007	J.C.
370	342,318,335	03/22/2007	J.C.
375	299,346	03/22/2007	J.C.

SEARCH NOTES		
Search Notes	Date	Examiner
EAST Image and keyword search in USPAT, US-PG Pub, DERWENT, EPO, JPO and IBM_TDB	03/22/2007	J.C.

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner